Effect of doping and sintering in structure and magnetic properties of the diluted magnetic semiconductor ZnO: Ni

(Efeito da dopagem e sinterização na estrutura e propriedades magnéticas do semicondutor magnético diluído ZnO: Ni)

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Abstract

This work aimed to study a sintered Ni-doped ZnO dilute magnetic semiconductor synthesized by means of a combustion reaction and to evaluate the effect of doping and sintering in the band gap and magnetic properties of the material. X-ray diffraction showed the formation of the ZnO semiconductor phase and also the formation of a second-phase characterized as a solid solution of nickel-zinc oxide. The hysteresis curves showed the success in creating ferromagnetism with doping and the effect of sintering in the remanent magnetization and coercive field values, yet both systems were able to maintain its ferromagnetic behavior. The UV-vis analysis indicated the value of the band gap continued as a semiconductor material, although it has been narrowed. Scanning electron microscopy was used in a complementary way to evaluate the morphology and its effects on magnetic properties.

Keywords: dilute magnetic semiconductor, sintering, ferromagnetism, combustion reaction.

INTRODUCTION

Diluted magnetic semiconductors (DMS) are materials in which transition metals or rare earth ions are doped in the crystalline lattice, giving rise to ferromagnetic properties in the doped semiconductor. The possibility of joining these properties attracted attention for a wide range of electrical, optical and magnetic applications in the area of spintronics, such as data storage [1], spin-LED [2], nonvolatile memories [3], and many others. Spintronics is based on controlling the spin of the electrons, by applying electrical fields or optical stimulus [4]. For this, materials with ferromagnetism and semiconducting properties are required. Since the most used semiconductors do not have suitable magnetic properties, it is necessary to introduce the ferromagnetism. The main way to obtain ferromagnetic semiconductors is doping with transition metal (TM) ions (Fe, Cr, V, Ni, Mn) in semiconducting hosts, such as TiO₂ [5], ZnS [6], and ZnO [7]. Wide band gap semiconductors are used for the production of DMS by many synthesis techniques and presenting ferromagnetism at room temperature [8]. Zinc oxide (ZnO) is a semiconductor material with applications ranging from electronics to biomaterials and medical fields, has a wide energy gap between 3.2 and 3.4 eV and can be easily produced by many techniques [9]. As a DMS, zinc oxide has been reported by numerous synthesis routes, showing ferromagnetism at or above room temperature.

A simple synthesis route to prepare ferromagnetic DMS ZnO is the combustion reaction [10, 11]. This process consists of a rapid and exothermic chemical reaction, useful in the production of many ceramic nanopowders. During the reaction, high temperatures can be achieved by the decomposition of a fuel-oxidizer mixture; this contributes to eliminate impurities and ensure crystallization of the products. The process can be controlled by changing parameters like heating rate, stoichiometry of reactants.
and volume of the container [12]. The calculations of fuel-oxidizer stoichiometry can be done with the method described in [13], taking into consideration the oxidation number of all reducing and oxidizing elements of the reactants. As almost every material requires some kind of treatment to reach its final use (e.g., to give form or mechanical strength), which can affect the final properties of the material, this work aims to sinter an already synthesized and studied Ni-doped ZnO by combustion reaction [14, 15], and to evaluate the effects of the heat-treatment in the crystalline structure, morphology and magnetic properties of the DMS.

MATERIALS AND METHODS

The reactants were zinc nitrate hexahydrate, Zn(NO$_3$)$_2$.6H$_2$O, nickel nitrate hexahydrate, Ni(NO$_3$)$_2$.6H$_2$O, and urea, CO(NH$_2$)$_2$, as fuel (all reagents from Vetec with 98% purity). The system formed was Zn$_{1-x}$Ni$_x$O, with x being 0.08 and 0.15 mol of Ni. The system formation reaction was:

$$(1-x)\text{Zn(NO}_3\text{)}_2.6\text{H}_2\text{O}+x\text{Ni(NO}_3\text{)}_2.6\text{H}_2\text{O}+n\text{CO(NH}_2\text{)}_2 \rightarrow \text{Zn}_1\text{Ni}_x\text{O} + \text{gas (N}_2\text{, CO}_2\text{, H}_2\text{O)}$$  \hspace{1cm} (A)

The number of moles, n, of fuel was determined based on the total valence of the oxidants and reducers [13]. The reaction was performed in a silica crucible, heated by an electric resistance at 500 °C until reached ignition. The reaction product was dried in a muffle furnace at 500 °C for 5 min and then de-agglomerated with a 325-mesh (45 μm) sieve. The powder was then pressed with a load of 2 ton for 1 min, relieved and then pressed again with the same load and time, resulting in small pellets. The sintering was performed in a muffle furnace by heating at 10 °C/min, holding at 1000 °C for 2 h, and then cooled inside the furnace to room temperature. After that, the samples were characterized by the following methods. X-ray diffraction (XRD) was done with the Shimadzu XRD-6000 diffractometer, in the 2θ range of 30-75°, with 2°/min scanning rate, CuK$_\alpha$ radiation (1.5406 Å), 30 kV voltage and 30 mA current. The hysteresis curves were obtained with vibrating sample magnetometry, VSM LakeShore mod. 7404. The hysteresis cycles were performed at 300 K, with a maximum applied field of 7k Oe at a rate of 5 Oe/s. The material band gap was studied using the UV-vis technique with Shimadzu UV-2550 spectrophotometer (wavelength range of 200-900 nm). The morphology of the material was analyzed by scanning electron microscopy (SEM) with the LEO 1430 microscope.

RESULTS AND DISCUSSION

Fig. 1 shows the X-ray diffraction patterns for undoped ZnO and ZnO:Ni systems. The original ZnO wurtzite hexagonal structure (space group P63mc) was maintained for all studied concentrations. The peaks indicated by Z corresponded to zinc oxide (ZnO) and all the reflection planes were the same as the wurtzite structure found in the literature (ICSD 01-079-0208). Additionally, characteristic peaks of the nickel-zinc oxide solid solution, indicated by N (Ni$_6$Zn$_4$O, ICSD 01-075-0273), appeared in all Ni-doped systems, becoming stronger with the increase in Ni content. This solid solution is completely formed when NiO and ZnO mix is heated for 5 h at temperatures between 1000 and 1250 °C [16]. In this work, the samples were heated for only 2 h, so the solid solution was expected not be completely formed, and NiO was expected to be present. With doping, the peaks positions of the wurtzite structure were slightly shifted to greater 2θ, which characterize a decrease in the basal spacing of the respective diffraction planes. Table I shows the 20 positions and the interplanar spacing d for the reflection plane (101), the most intense diffraction for the ZnO wurtzite structure. The values were taken directly from the XRD diffractograms. The decrease in d is explained by the substitution of Zn$^{2+}$ for Ni$^{2+}$ ions and their radii (ionic radius of 0.74 and 0.69 Å, respectively). This decrease in d, which also correlated to decrease in lattice parameters, indicated that the Ni ions were incorporated in the structure.

Figure 1: X-ray diffraction patterns of ZnO:Ni systems (a), and displacement of (101) plane of HCP structure (b).

[Figura 1: Difratogramas de raios X dos sistemas ZnO: Ni (a) e deslocamento do plano (101) da estrutura HC (b).]
The formation of secondary phase can be explained by the difference in bond energy of Ni$^{2+}$-O$^{2-}$ and Zn$^{2+}$-O$^{2-}$. The nickel-oxygen bond has higher energy, which means that more energy is required to Ni$^{2+}$ ions enter the lattice and form the nickel-oxygen bond, when compared to zinc-oxygen bond. Hence, Ni$^{2+}$ ions have higher stability relative to Zn$^{2+}$ in Zn-O structure, requiring more energy to induce crystallization in doped systems [19]. Considering this, it was concluded that the energy of the combustion reaction was not enough to complete the dilution of Ni ions into the ZnO lattice.

Figs. 2 and 3 show the magnetic hysteresis of pure ZnO and ZnO:Ni systems. The cycle of the pure ZnO was characteristic of a diamagnetic material. In Table II the remanent magnetization (Mr) and coercive field (Hc) of both ZnO: Ni systems in powder form and after sintering (inset in Fig. 3) are presented. Hysteresis curves were obtained at room temperature and showed that both sintered systems were capable to maintain the ferromagnetism after the heat treatment. The presence of NiO/Ni$_6$Zn$_4$O phases negatively affected the magnetic moment of the material due to both oxides being antiferromagnetic [20]. With increased doping, the second-phase becomes more evident, so it was expected the magnetic moment to decrease. For the powder samples, this decrease only happened when the doping varied from 0.15 to 0.25 mol of Ni [14]. After sintering, the remanent magnetization (Mr) also decreased when the doping was 0.15 mol. Hou et al. [18] discuss the decrease in magnetization based on Ni$^{2+}$-Ni$^{2+}$ bond distance. In lower concentrations, the Ni$^{2+}$-Ni$^{2+}$ distance is longer, resulting in weaker ferromagnetic interaction, hence, remanent and saturation magnetizations are expected to be lower. This interaction is strongest on the highest magnetization. With further increase in Ni doping, the Ni$^{2+}$-Ni$^{2+}$ distance decrease, resulting in an antiferromagnetic arrangement of the Ni moments [18]. Another explanation for the lower magnetization is based on the morphology of the samples. Fig. 4 shows the SEM images of both sintered systems. It can be noted that the system with 0.15 mol of Ni had a denser structure and smaller particle size when compared to the system with 0.08 mol of Ni. It is known that a material with fewer defects (like porosity), larger grains and a denser structure favors the displacement of the walls of magnetic domains (the walls can move more freely), with a smaller pinning region, making the coercive field (Hc) and the remanent magnetization (Mr) smaller [21].

To determine the energetic gap of the material the Tauc method was used. In this method, the absorbance spectrum

<table>
<thead>
<tr>
<th>System</th>
<th>2θ (°)</th>
<th>d (Å)</th>
</tr>
</thead>
<tbody>
<tr>
<td>ICSD 01-079-0208</td>
<td>36.1000</td>
<td>2.4861</td>
</tr>
<tr>
<td>Pure ZnO</td>
<td>35.9573</td>
<td>2.4956</td>
</tr>
<tr>
<td>0.08 mol Ni</td>
<td>36.0051</td>
<td>2.4924</td>
</tr>
<tr>
<td>0.15 mol Ni</td>
<td>36.0034</td>
<td>2.4925</td>
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</tbody>
</table>

Table II - Remanent magnetization (Mr) and coercive field (Hc) before and after sintering.

<table>
<thead>
<tr>
<th>Mol of Ni</th>
<th>Mr (emu/g)</th>
<th>Hc (Oe)</th>
</tr>
</thead>
<tbody>
<tr>
<td>Powder</td>
<td></td>
<td></td>
</tr>
<tr>
<td>0.08</td>
<td>0.15516 ± 0.00014</td>
<td>-161.13 ± 0.02</td>
</tr>
<tr>
<td>0.15</td>
<td>0.18192 ± 0.00013</td>
<td>-174.74 ± 0.06</td>
</tr>
<tr>
<td>Sintered</td>
<td></td>
<td></td>
</tr>
<tr>
<td>0.08</td>
<td>(1.2979 ± 0.0009) x10$^{-4}$</td>
<td>-8.14 ± 0.14</td>
</tr>
<tr>
<td>0.15</td>
<td>(9.2411 ± 0.0026) x10$^{-5}$</td>
<td>-12.89 ± 0.03</td>
</tr>
</tbody>
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of the material was used to determine its absorption energy and to estimate the value of the electronic gap, given by:

\[(h\nu \text{abs})^n = A(h\nu - E_g)\]  \hspace{1cm} (B)

where: \(h\nu\) is the energy of the wavelength used in the UV-vis, given in electron-volt (eV), \(\text{abs}\) is the absorbance obtained in UV-vis spectrum, \(E_g\) is the band gap and \(A\) is a proportionality parameter. The value of index \(n\) is determined by the type of electronic transition of the studied material. For direct transitions, \(n\) is 2; for indirect transitions, \(n\) is 1/2 [22]. ZnO has a direct transition, with a gap varying between 3.2 and 3.4 eV. Plotting the left side of Eq. B on the y-axis and the energy on the x-axis gave the graphs shown in Fig. 5 for pure ZnO and Ni-doped samples. Extrapolating the linear regions until the x-axis is the cutoff, and the term \((h\nu \text{abs})^2=0\) (Eq. B). With this, the value corresponding to the intersection of the x-axis and the extrapolated line gave the energy value that is the band gap of the material. This approach worked for pure ZnO and gave a value of about 3.101 eV (Fig. 5a), which is close to that reported in the literature for the ZnO band gap. Table III lists the gaps values for the ZnO:Ni systems. The band gap for the doped samples was smaller when compared to pure ZnO, meaning that the band gaps were redshifted. The cause for this redshift is attributed to sp-d exchange interactions of d-electrons from Ni\(^{2+}\) and band electrons [23, [Figura 4: Micrografias de MEV dos sistemas sinterizados: a) 0.08 mol de Ni; e b) 0.15 mol de Ni.]

Figure 4: SEM micrographs of sintered systems: a) 0.08 mol of Ni; and b) 0.15 mol of Ni.

[Figura 5: Gráfico de Tauc para determinação do band gap de: a) ZnO puro; b) amostra com 0.08 mol de Ni; e c) amostra com 0.15 mol de Ni.]
Table III - Values of band gap of ZnO:Ni systems.

<table>
<thead>
<tr>
<th>Mol of Ni</th>
<th>Eg (eV)</th>
</tr>
</thead>
<tbody>
<tr>
<td>0.08</td>
<td>2.833 ± 0.002</td>
</tr>
<tr>
<td>0.15</td>
<td>2.881 ± 0.004</td>
</tr>
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</table>

CONCLUSIONS

The energy availability of the thermal treatment contributed to the increase of the content of second-phases (higher energy for diffusion of the Ni ions in the lattice), which in turn increased the antiferromagnetic characteristics of the systems, negatively affecting the desired ferromagnetism. The sintering process also contributed to a greater densification of the material, making it denser, and consequently, leaving the magnetic domains with freer movement. The UV-vis analysis suggested that both systems suffered a narrowing in the band gap and confirmed that Ni ions remained in the ZnO tetrahedral sites after the sintering treatment. It is confirmed that even after a heat treatment at temperatures as high as 1000 °C the material can sustain the properties desired for a diluted magnetic semiconductor.

ACKNOWLEDGMENT

The authors are grateful for the financial support of the CNPq Scientific Initiation Program (PIBIC).

REFERENCES


(Rec. 26/03/2018, Rev. 07/05/2018, Ac. 05/07/2018)